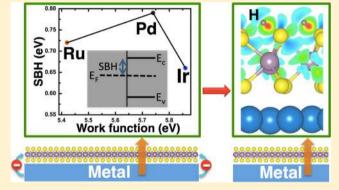


# Tuning the Electronic and Chemical Properties of Monolayer MoS<sub>2</sub> Adsorbed on Transition Metal Substrates

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**ABSTRACT:** Using first-principles calculations within density functional theory, we investigate the electronic and chemical properties of a single-layer  $MoS_2$  adsorbed on Ir(111), Pd(111), or Ru(0001), three representative transition metal substrates having varying work functions but each with minimal lattice mismatch with the  $MoS_2$  overlayer. We find that, for each of the metal substrates, the contact nature is of Schottky-barrier type, and the dependence of the barrier height on the work function exhibits a partial Fermi-level pinning picture. Using hydrogen adsorption as a testing example, we further demonstrate that the introduction of a metal substrate can substantially alter the chemical reactivity of the adsorbed  $MoS_2$  layer. The enhanced binding of hydrogen, by as much as  $\sim 0.4$  eV, is attributed in part to a stronger H–S coupling



enabled by the transferred charge from the substrate to the  $MoS_2$  overlayer, and in part to a stronger  $MoS_2$ -metal interface by the hydrogen adsorption. These findings may prove to be instrumental in future design of  $MoS_2$ -based electronics, as well as in exploring novel catalysts for hydrogen production and related chemical processes.

**KEYWORDS:** Density functional theory, MoS<sub>2</sub>-metal contacts, Schottky barrier, hydrogen adsorption, catalyst

s a transition-metal dichalcogenide semiconductor, MoS<sub>2</sub> A is a commonly used dry lubricant, whose low-dimensional structures are receiving much research attention because of their distinctive electronic,  $^{1-3}$  optical,  $^{1,4-6}$  and catalytic properties.  $^{7-11}$  Bulk MoS<sub>2</sub> has a layered structure, each layer consisting of a covalently bonded S-Mo-S hexagonal quasitwo-dimensional network, 12,13 with weak van der Waals (vdW) attraction between the layers. Owing to the relatively weak interlayer interaction, a monolayer of MoS2 can be mechanically exfoliated from a MoS<sub>2</sub> crystal. 14 Such monolayer systems not only have a direct band gap with highly desirable optical properties<sup>1</sup> but also possess sufficiently high carrier mobility for potential applications in nanoelectronics.<sup>15</sup> In exploring the device potential of monolayer MoS<sub>2</sub>, it is vital to understand how such systems interface with metallic contacts, similar to recent developments in other areas of nanomaterials such as semiconductor wires, carbon nanotubes, 16,17 and graphene. 18 In particular, it was found recently that both the barrier height for electron tunneling and the nature of contact between MoS2 and an electrode can be drastically altered when using different types of metal contacts. 19 Furthermore, on a different front, monolayer-high MoS<sub>2</sub> islands adsorbed on different metal substrates have been shown to be highly catalytic in hydrogen evolution reaction (HER),  $^{8-11}$  with the reactivity largely attributed to the edge sites of the islands.

In this Letter, we use first-principles calculations within density functional theory (DFT) to investigate the electronic and chemical properties of a single-layer MoS2 adsorbed on Ir(111), Pd(111), or Ru(0001), three representative transition metal substrates having varying work functions but each with minimal lattice mismatch with the MoS<sub>2</sub> overlayer. We find that for each of the metal substrates, the contact nature is of Schottky-barrier type, and the dependence of the barrier height on the work function establishes a partial Fermi-level (FL) pinning picture.<sup>20</sup> Using hydrogen adsorption as a testing example, we further demonstrate that the introduction of a metal substrate can substantially alter the chemical reactivity of the adsorbed MoS<sub>2</sub> layer. Our detailed analysis of the electron density redistribution reveals that the enhanced binding of hydrogen, by as much as ~0.4 eV, is attributed in part to a stronger H-S coupling enabled by the transferred charge from the substrate to the MoS<sub>2</sub> overlayer, and in part to a stronger MoS<sub>2</sub>-metal interface by the hydrogen adsorption. These

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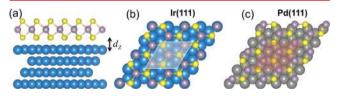
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findings may prove to be instrumental in future design of MoS<sub>2</sub>-based electronics, as well as in exploring novel catalysts for hydrogen production and related chemical processes.

Our DFT calculations were carried out using the Vienna ab *initio* simulation package (VASP)<sup>21</sup> with projector-augmented wave (PAW) pseudopotentials<sup>22,23</sup> and the Ceperley-Alder local density approximation (LDA)<sup>24</sup> as parametrized by Perdew and Zunger<sup>25</sup> for the exchange-correlation functional. Unless otherwise specified, the results presented were from LDA calculations. For Pd and Ru as substrates, we have also compared the LDA results with those from DFT-D2, 26,27 a semiempirical approach that includes vdW interactions, to cross check on the accuracy as well as the overall trends of the LDA results.<sup>28</sup> The lattice constants of the metals and the monolayer MoS<sub>2</sub> were obtained via structural optimization. The metal substrates were modeled by slabs of 8 atomic layers, and the MoS<sub>2</sub>-metal systems were modeled by placing a single-layer MoS<sub>2</sub> on top of the metal surfaces. A vacuum region more than 15 Å was used to ensure decoupling between neighboring slabs. During structural relaxation, only the bottom layer atoms were fixed in their respective bulk positions, with all the other atoms fully relaxed until the force on any given atom is smaller than 0.01 eV/Å. A 6  $\times$  6  $\times$  1 k-point mesh was used for the 2  $\times$  2 surface unit cell of metals.<sup>29</sup> When H adsorption was considered, we also examined the effect of spin polarization in our calculations. The spin-orbit coupling effect has also been checked for the heaviest element, Ir, and the detailed results indicate that it has only negligible influence on the energetics.

We choose Ir(111), Pd(111), and Ru(0001) as substrates mainly because a ( $\sqrt{3} \times \sqrt{3}$ ) R30° unit cell of MoS<sub>2</sub> can nicely match with a 2 × 2 unit cell of Ir(111), Pd(111), or Ru(0001), as illustrated in Figure 1. The maximum mismatch is ~1.2% for



**Figure 1.** (a) Side and (b) top views of monolayer  $MoS_2$  on the Ir(111) substrate. (c) Top view of  $MoS_2$  on the Pd(111) substrate. In b and c, the white- and red-shaded areas show the unit cells in the calculations, respectively.

Ru(0001), with varying work functions of 5.86 eV, 5.74 eV, and 5.42 eV for Ir(111), Pd(111), and Ru(0001), respectively. In our calculations, the surface lattices of the metal substrates were fixed to their optimized values and the in-plane lattice of MoS<sub>2</sub> was adjusted to match the metal substrates accordingly. The most stable contact geometries were obtained by optimizing the structures from different initial configurations. For all of the systems, the top layer of the metal substrates and the bottom S layer of MoS<sub>2</sub> essentially stay planar after relaxation, with the MoS<sub>2</sub>-metal distances listed in Table 1. However, the relative positions between MoS<sub>2</sub> and the substrates along the interface directions are different for different metals. On Ir(111), the three Mo atoms in the supercell sit above the fcc hollow, hcp hollow, and top sites, respectively (Figure 1b); while on Pd(111), the Mo atoms are all above the centers of the triangles formed by the fcc, hcp, and top sites (Figure 1c). The registry of MoS<sub>2</sub> relative to the top layer of Ru(0001) is similar to that of Ir(111) and is therefore omitted in Figure 1. The MoS<sub>2</sub>-

Table 1. Structural and Energetic Results for All of the Free-Standing MoS<sub>2</sub> and MoS<sub>2</sub>-Metal Systems<sup>a</sup>

	$\frac{E_{\rm b}}{({ m eV})}$	$d_z^0$ (Å)	$d_z^{\mathrm{H}}$ $(\mathrm{ ilde{A}})$	(eV)	$(A)^{L_{H-S}}$	$\theta$ (deg)
free-standing MoS <sub>2</sub>				1.07	1.46	40.2
$MoS_2/Ir(111)$	0.62	2.23	2.20	1.44	1.43	37.2
$MoS_2/Pd(111)$	0.74	2.17	2.09	1.39	1.39	89.1
$MoS_2/Ru(0001)$	0.82	2.25	2.20	1.33	1.46	38.2

 $^aE_b$  is the binding energy per sulfur atom between MoS<sub>2</sub> and a given substrate;  $d_z^0$  and  $d_z^H$  are the distances between MoS<sub>2</sub> and a given metal substrate without and with H adsorption, respectively;  $E_a$  is the H binding energy on the planar surface of a free-standing MoS<sub>2</sub> or a MoS<sub>2</sub> overlayer on a given substrate;  $L_{H-S}$  is the H–S bond length;  $\theta$  is the angle between the H–S bond and the planar surface of MoS<sub>2</sub>.

metal binding energies per interfacial sulfur atom, calculated as  $E_{\rm b} = (E_{\rm MoS_2} + E_{\rm metal} - E_{\rm MoS_2/metal})/3$ , range from 0.62 to 0.82 eV as listed in Table 1. The inclusion of the vdW interactions increases the binding energy by 0.16 eV for Pd and 0.19 eV for Ru; furthermore, the GGA-vdW results also reduce the interfacial distances between the MoS\_2 overlayer and the metal substrates to be close to the LDA results. The even stronger binding energies of the vdW results over LDA, which tends to overestimate the binding, <sup>30</sup> should be attributed to the significant attractive contributions of vdW interactions.

To identify the energy level alignment at the interface between MoS<sub>2</sub> and the metal substrates, we have calculated the band structures of MoS<sub>2</sub> and the combined systems. As seen in Figure 2a, the original K point of the  $1 \times 1$  unit cell where the band edge is located, is folded to the  $\Gamma$  point in the reciprocal space of the  $\sqrt{3} \times \sqrt{3}$  superlattice of single-layer MoS<sub>2</sub>. The calculated band gap is ~1.8 eV, consistent with previous results.<sup>1,2</sup> In the combined systems, although the energy bands of MoS<sub>2</sub> hybridize with those of the metals to a certain extent, the majority of the MoS<sub>2</sub> bands can still be identified, as marked in red in Figure 2b-d. The FLs of the combined systems always lie in the band gap region of MoS2, resulting in the formation of a Schottky barrier at the interface for each case. The calculated n-type Schottky barrier heights corresponding to the energy differences between the conduction band minimum and the FLs are 0.66 eV, 0.79 eV, and 0.72 eV for Ir, Pd, and Ru, respectively (Figure 2e). The maximal work function difference is 0.44 eV, while the maximal difference in the Schottky barrier heights is 0.13 eV; we therefore observe a partial FL pinning picture<sup>20</sup> when the three metals form contacts with monolayer MoS<sub>2</sub>. As for likely pinning mechanisms, the picture of metalinduced gap states is typically operative deep in the semiconductor,<sup>31</sup> suggesting that a single layer of MoS<sub>2</sub> is unlikely to cause strong FL pinning, consistent with the present study. Alternatively, we expect that the sufficiently strong chemical bonding at the interface, the other pinning mechanism,<sup>32</sup> may have also contributed to the pinning effects.

There is another angle to view the electronic properties and contact nature at the MoS<sub>2</sub>-metal interfaces. If the FL pinning effects were absent, we would have expected Schottky barrier heights of roughly 1.5 eV, 1.4 eV, and 1.1 eV for Ir, Pd, and Ru, respectively, given by the separations between the conduction band minimum and the FL of the monolayer MoS<sub>2</sub> subtracted by the respective work function differences of MoS<sub>2</sub> and Ir, Pd, or Ru. The observed Schottky barrier heights indicate that there exist pronounced FL shifts of the adsorbed MoS<sub>2</sub>, given by ~1.11 eV, 0.98 eV, and 1.05 eV for Ir, Pd, and Ru, respectively.

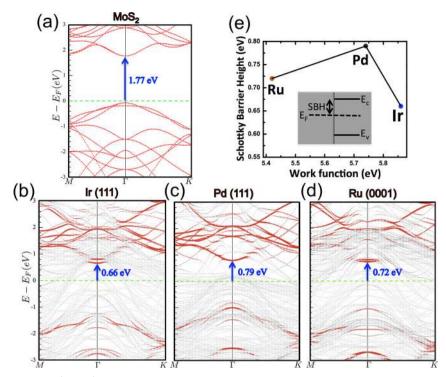


Figure 2. Band structures of (a) a  $\sqrt{3} \times \sqrt{3}$  superlattice of monolayer MoS<sub>2</sub>, (b) MoS<sub>2</sub>-Ir(111), (c) MoS<sub>2</sub>-Pd(111), and (d) MoS<sub>2</sub>-Ru(0001) interfaces. The Fermi energy  $E_F$  is set to zero in all of the four panels and is indicated by the green dashed lines. In b-d, the red lines correspond to the energy bands of the monolayer MoS<sub>2</sub>, and the numbers in blue are the Schottky barrier heights, whose dependence on the work function of the metal substrate is plotted in e.

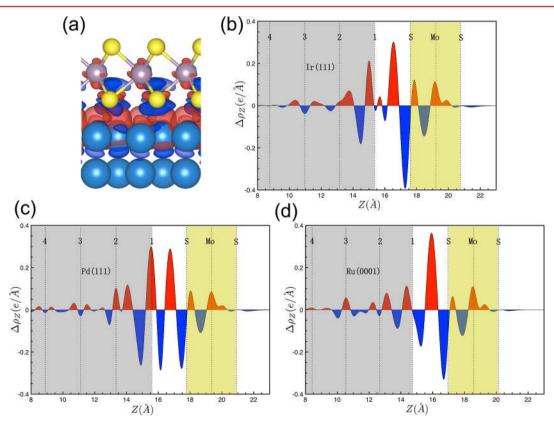


Figure 3. (a) Side view of the charge difference between the combined  $MoS_2$ –Ir(111) system and the sum of the isolated  $MoS_2$  and Ir substrate. (b–d) Plots of the plane-averaged electron density difference along the direction perpendicular to the interface ( $\Delta \rho_z$ ) of  $MoS_2$ –Ir(111) (b),  $MoS_2$ –Pd(111) (c), and  $MoS_2$ –Ru(0001) (d). For each case, the reference location Z=0 Å is taken to be the position of the bottom layer of the metal substrate in the slab. The red and blue colors indicate electron accumulation and depletion, respectively.

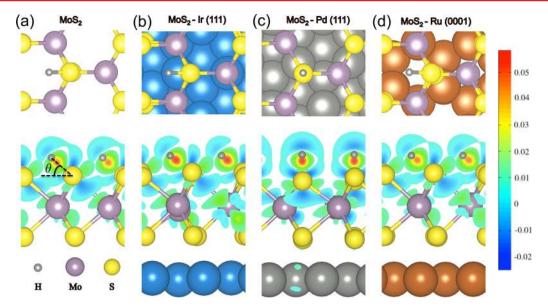


Figure 4. Top views of the bonding geometries (upper row) and cross-sectional views of the charge transfer density (lower row) between a H atom and (a) a free-standing  $MoS_2$ , (b) the  $MoS_2/Ir(111)$ , (c)  $MoS_2/Pd(111)$ , and (d)  $MoS_2/Ru(0001)$  systems. The red and blue colors represent the maximum charge accumulation and maximum charge depletion, respectively.

Similarly, additional FL shifts of up to  $\sim$ 0.5 eV were also observed in a previous study of graphene—metal contacts. <sup>33,34</sup> In both cases, such FL shifts can be induced by the resultant effects of charge transfer at the interfaces and chemical bonding effects; the larger and nonlinear FL shifts are also consistent with the much stronger and varying chemical bondings in the present systems.

To further illustrate the detailed nature of the charge transfer at the MoS<sub>2</sub>-metal interfaces, we show in Figure 3a the charge difference between the combined MoS<sub>2</sub>-Ir(111) system and the sum of the isolated MoS<sub>2</sub> and Ir substrate. The electronic structures of the isolated MoS2 and Ir substrate were calculated by freezing the atomic positions of the respective components as obtained in the combined system. The red regions represent accumulation, and the blue regions represent depletion of electrons in the combined system relative to the two isolated components. To have a quantitative picture, we plot in Figure 3b-d the plane-averaged electron density difference  $\Delta \rho_z$  along the perpendicular direction to the interface. Several charge transfer oscillations are observed at the interfacial region, and some extra charge is found to accumulate around the Mo atoms. Since the position of  $MoS_2$  on Pd(111) is different from that on Ir(111) or Ru(0001), there is a net charge accumulation in the first layer of the Pd substrate closest to MoS<sub>2</sub> (Figure 3c), while the first layer of the Ir and Ru substrates is located at places where the net charge transfer is negligible (Figure 3b and d). Overall, the oscillatory nature of the charge transfer at the interfaces is complex, but our analysis on the FL shifts given above indicates that the adsorbed MoS<sub>2</sub> is net n-type doped by the three investigated metals.

Aside from the transport properties for potential electronic device applications, the significant charge transfer at the MoS<sub>2</sub>-metal contacts is also expected to affect the chemical properties of the MoS<sub>2</sub> overlayer. To explore the possibility of tuning the chemical reactivity on the planar surface of MoS<sub>2</sub> through metal substrates, we consider HER as a testing case, which is fundamentally important in a variety of electrochemical processes of technological significance. Currently the most efficient HER catalyst is Pt, which is a precious metal, making it

highly desirable to find alternative catalysts based on materials that are abundant and of low cost. MoS2 has been demonstrated the ability to function as a HER catalyst, but only the edge sites of the monolayer MoS2 clusters were identified to be chemically reactive while the planar surface is rather inert.<sup>10</sup> Due to the small lattice mismatches between MoS<sub>2</sub> and the metal substrates considered here, it is expected that large-scale monolayer MoS2 sheets can be grown on these substrates. Although the planar surface of MoS<sub>2</sub> cannot be as catalytic as the edge sites, considering the large area of the planar surfaces, it is appealing to gain stronger overall reactivity by making the whole planar surfaces sufficiently catalytic. A critical step in HER is that a H+ ion gains an electron from the electrode, becoming an atomic H, whose binding energy on the catalytic MoS2 overlayer placed on the electrode is yet another vital energy scale determining the overall HER efficiency. For this important reason and also for simplicity, we study the influence of different metal substrates on the adsorption energy of atomic H on the MoS<sub>2</sub> overlayer, leaving the electron capture process of H<sup>+</sup> for a future study.

To find the most stable adsorption site of H on the surface of a given MoS<sub>2</sub> overlayer, we have examined all possible initial positions based on symmetry considerations. Figure 4 depicts the top and side views of the most stable H adsorption geometries on the three metal substrates. The corresponding adsorption energies, calculated as  $E_{\rm a}=E_{\rm hydrogen}+E_{\rm substrate}$  –  $E_{\rm hydrogen/substrate}$ , are 1.44 eV, 1.39 eV, and 1.33 eV for Ir, Pd, and Ru, respectively (Table 1), all of which are substantially enhanced from the value of 1.07 eV on a free-standing MoS<sub>2</sub>. We have verified that the DFT-D2 calculations yield only slightly enhanced binding energies over the LDA results (by less than 0.02 eV). In addition to the binding energy differences, we also observe geometrical differences between the considered systems, as measured by  $\theta$ , the angle between the H-S bond and the planar surface of MoS<sub>2</sub>. As shown in Figure 4 and Table 1, for the systems of MoS<sub>2</sub>-Ir(111) and  $MoS_2$ -Ru(0001),  $\theta$  is 37.2° and 38.2°, similar to the angle of 40.2° on the free-standing MoS<sub>2</sub>. In contrast, the H adatom prefers an atop position on MoS<sub>2</sub>-Pd(111), with  $\theta \approx 90^{\circ}$ ,

caused by the dramatically different atomic registry between the MoS<sub>2</sub> overlayer and the first layer of the Pd substrate when compared with the other two substrates. Collectively, these results show that both the H binding energy and binding geometry can be tuned with a proper choice of the metal electrode; such tunabilities, in turn, can significantly affect the HER efficiency of the planar MoS<sub>2</sub> overlayer.

To reveal the physical origin of the substrate-enhanced H binding energy, we have calculated the charge transfer between H and the surfaces measured by  $\Delta \rho = \rho_{\rm H/MoS_2/metal} - \rho_{\rm H}$   $ho_{
m MoS_2/metal}$ . The panels shown in the lower row of Figure 4 display the side views of the contour plots of  $\Delta \rho$ , taken in the plane normal to the interface and across the H-S bond. We see a clear indication that more charge is involved in the covalent H-S bonds on the Ir(111) and Pd(111) substrates, which is also consistent with the shortened bond lengths shown in Table 1. In contrast, little change is observed in the H-S bond on Ru(0001) from the free-standing MoS<sub>2</sub> case, consistent with the observation that the enhancement in the adsorption energy is the smallest among the three metals. Aside from the charge redistribution between the H adatom and the MoS<sub>2</sub> overlayer, we can also investigate the effect of H adsorption on the coupling between the MoS2 and the substrate. Such effects could be quantified by variations in  $d_z^H$ , defining the maximum separation of the sulfur atoms in the lower layer of MoS2 from the topmost layer of the metal substrate. When compared with  $d_z^0$ , the separation without the presence of H,  $d_z^H$  becomes smaller by 0.03 Å, 0.08 Å, and 0.05 Å for Ir, Pd, and Ru, respectively. These results demonstrate that the enhancements in the adsorption energy arise from two aspects: one is the stronger H-S covalent bonding enabled by the transferred charge from the metal substrates to MoS2; the other is associated with the stronger MoS2-metal interfaces caused by the H adatom serving as a "nail" to pin the MoS2 and substrate together.

Before closing, we note that the significant net charge transfer from the metal substrates to the  $MoS_2$  overlayer will likely have an even stronger effect on the electron capture process of  $H^+$  ion. This intriguing possibility will be examined in a future study of a more complete HER cycle.

In summary, we have investigated the electronic and chemical properties of a single-layer MoS2 adsorbed on Ir(111), Pd(111), or Ru(0001). We found that for each of the metal substrates, the contact nature is of Schottky-barrier type, and the dependence of the Schottky barrier height on the work function establishes a partial Fermi-level pinning picture for these systems. We have further demonstrated that the introduction of a metal substrate can substantially alter the H binding energy on the MoS<sub>2</sub> overlayer. A detailed analysis of the electron density redistribution revealed that the enhanced binding of hydrogen is the result of a stronger H-S coupling enabled by the transferred charge from the substrate to the MoS<sub>2</sub> overlayer, and a stronger MoS<sub>2</sub>-metal interaction caused by the hydrogen adsorption. These findings may prove to be instrumental in future design of MoS2-based electronics, as well as in searching for novel catalysts for hydrogen production and related chemical processes.

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#### Notes

The authors declare no competing financial interest.

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